Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,886	MIKURIYA ET AL.	
Examiner	Art Unit	
John I. Goodrow	1756	

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Class	Subclass	Date	Examiner
430	110.2	9/18/06	JG
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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